

<b>Notice of References Cited</b>	Application/Control No. 09/242,191		Applicant(s)/Patent Under Reexamination RIERA, MICHEL	
	Examiner Thao T. Tran		Art Unit 1711	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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